

Application No.	on No. Applicant(s)	
10/601,626	JIEN, LEE-WEN	
Examiner	Art Unit	
Mark A. Williams	3676	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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